

# MJ N-Channel Enhancement Mode Power MOSFET

## Description

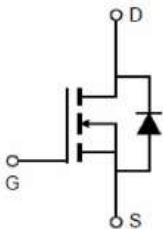
The MJ33H29D uses advanced trench technology and design to provide excellent  $R_{DS(ON)}$  with low gate charge. It can be used in a wide variety of applications.

## General Features

- ◆  $V_{DS}=33V, I_D=290A$   
 $R_{DS(ON)} < 1.8m\Omega @ V_{GS}=10V$
- ◆ High density cell design for ultra low  $R_{dson}$
- ◆ Fully characterized avalanche voltage and current
- ◆ Good stability and uniformity with high  $E_{AS}$
- ◆ Excellent package for good heat dissipation
- ◆ Special process technology for high ESD capability

## Application

- ◆ Power switching application
- ◆ Hard switched and High frequency circuits
- ◆ Uninterruptible power supply



Schematic diagram



TO-263-2L top view

100% UIS TESTED! 100%  $\Delta V_{ds}$  TESTED!

## Package Marking and Ordering Information

Device Marking	Device	Device Package	Reel Size	Tape width	Quantity
MJ33H29D	MJ33H29D	TO-263-2L	-	-	-

## Absolute Maximum Ratings ( $T_A=25\text{ }^{\circ}\text{C}$ unless otherwise noted)

Parameter	Symbol	Limit	Unit
Drain-Source Voltage	$V_{DS}$	33	V
Gate-Source Voltage	$V_{GS}$	$\pm 20$	V
Drain Current-Continuous	$I_D$	290	A
Drain Current-Continuous( $T_C=100^{\circ}\text{C}$ )	$I_{D(100^{\circ}\text{C})}$	205	A
Pulsed Drain Current	$I_{DM}$	1160	A
Maximum Power Dissipation	$P_D$	270	W
Derating factor		1.8	W/ $^{\circ}\text{C}$
Single pulse avalanche energy <sup>(Note 5)</sup>	$E_{AS}$	1300	mJ
Operating Junction and Storage Temperature Range	$T_J, T_{STG}$	-55 To 175	$^{\circ}\text{C}$

## Thermal Characteristic

Thermal Resistance, Junction-to-Case <sup>(Note 2)</sup>	$R_{\theta JC}$	0.56	$^{\circ}\text{C/W}$
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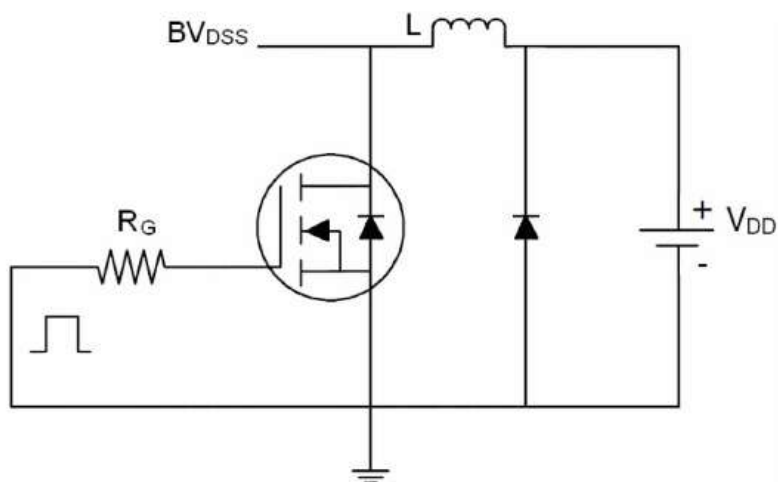
Electrical Characteristics (T<sub>A</sub> =25℃unless otherwise noted)

Parameter	Symbol	Condition	Min	Typ	Max	Unit
Off Characteristics						
Drain-Source Breakdown Voltage	BV <sub>DSS</sub>	V <sub>GS</sub> =0V I <sub>D</sub> =250μA	33	-	-	V
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>DS</sub> =33V,V <sub>GS</sub> =0V	-	-	1	μA
Gate-Body Leakage Current	I <sub>GSS</sub>	V <sub>DS</sub> =±20V,V <sub>GS</sub> =0V	-	-	±100	nA
On Characteristics <sup>(Note 3)</sup>						
Gate Threshold Voltage	V <sub>GS(th)</sub>	V <sub>DS</sub> =V <sub>GS</sub> ,I <sub>D</sub> =250μA	2	3	4	V
Drain-Source On-State Resistance	R <sub>DS(ON)</sub>	V <sub>GS</sub> =10V, I <sub>D</sub> =160A	-	1.4	1.8	mΩ
Forward Transconductance	g <sub>FS</sub>	V <sub>DS</sub> =5V,I <sub>D</sub> =160A	50	-	-	S
Dynamic Characteristics <sup>(Note 4)</sup>						
Input Capacitance	C <sub>iss</sub>	V <sub>DS</sub> =15V,V <sub>GS</sub> =0V F=1.0MHz	-	7848	-	PF
Output Capacitance	C <sub>oss</sub>		-	2046	-	PF
Reverse Transfer Capacitance	C <sub>rss</sub>		-	1516	-	PF
Switching Characteristics <sup>(Note 4)</sup>						
Turn-on Delay Time	t <sub>d(on)</sub>	V <sub>DD</sub> =15V,R <sub>L</sub> =15Ω R <sub>G</sub> =2.5Ω,V <sub>GS</sub> =10V	-	17	-	nS
Turn-on Rise Time	t <sub>r</sub>		-	160	-	nS
Turn-Off Delay Time	t <sub>d(off)</sub>		-	80	-	nS
Turn-Off Fall Time	t <sub>f</sub>		-	100	-	nS
Total Gate Charge	Q <sub>g</sub>	I <sub>D</sub> =160A,V <sub>DD</sub> =15V V <sub>GS</sub> =10V	-	168	-	nC
Gate-Source Charge	Q <sub>gs</sub>		-	32.5	-	nC
Gate-Drain Charge	Q <sub>gd</sub>		-	72.9	-	nC
Drain-Source Diode Characteristics						
Diode Forward Voltage <sup>(Note 3)</sup>	V <sub>SD</sub>	V <sub>GS</sub> =0V,I <sub>S</sub> =160A	-	0.85	1.2	V
Diode Forward Current <sup>(Note 2)</sup>	I <sub>S</sub>		-	-	290	A
Reverse Recovery Time	t <sub>rr</sub>	T <sub>J</sub> =25°C, I <sub>F</sub> =160A di/dt=100A/μs <sup>(Note 3)</sup>	-	45	-	nS
Reverse Recovery Charge	Q <sub>rr</sub>		-	160	-	nC
Forward Turn-On Time	t <sub>on</sub>	Intrinsic turn-on time is negligible(turn-on is dominated by LS+LD)				

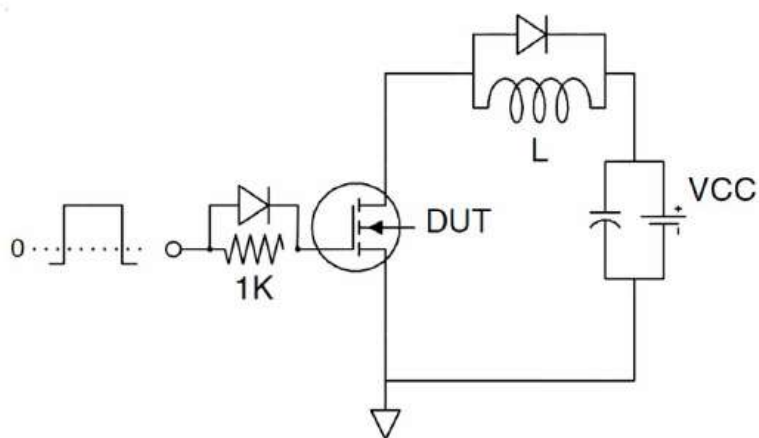
## Notes:

- ① Repetitive Rating: Pulse width limited by maximum junction temperature.
- ② Surface Mounted on FR4 Board, t ≤ 10 sec.
- ③ Pulse Test: Pulse Width ≤ 300μs, Duty Cycle ≤ 2%.
- ④ Guaranteed by design, not subject to production
- ⑤ EAS condition: T<sub>J</sub>=25℃,V<sub>DD</sub>=15V,V<sub>G</sub>=10V,L=0.5mH,R<sub>g</sub>=25Ω

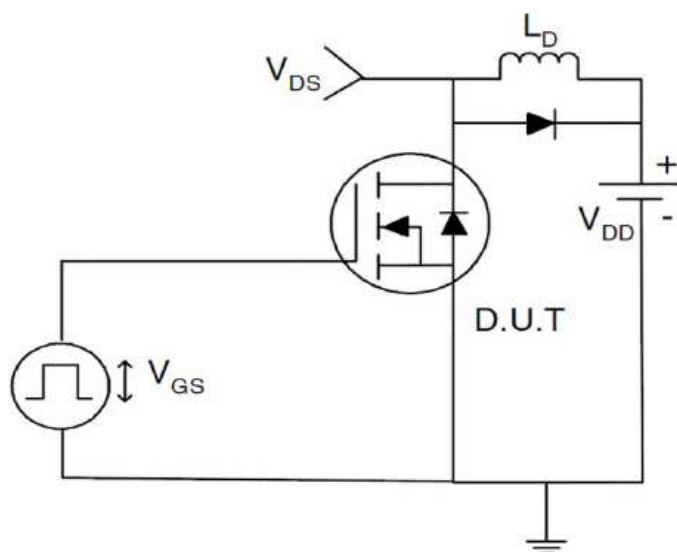
## Test circuit



EAS test Circuit

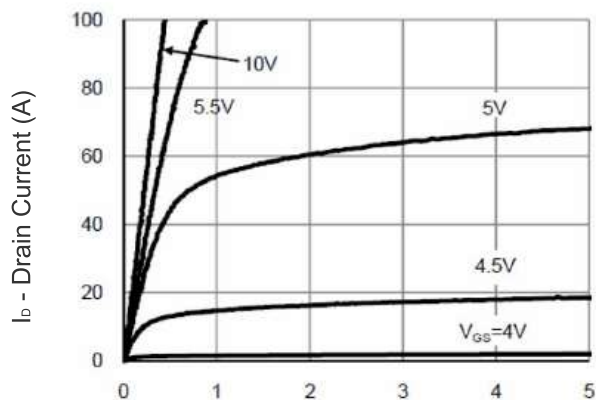


Gate charge test Circuit

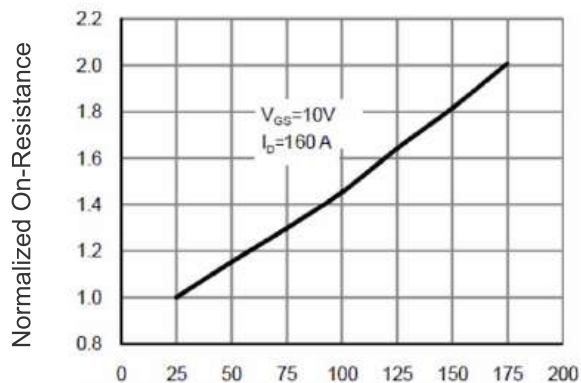


Switch Time Test Circuit

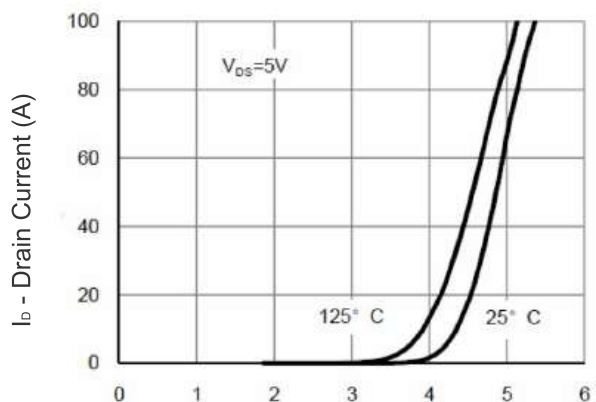
# Typical Electrical and Thermal Characteristics (Curves)



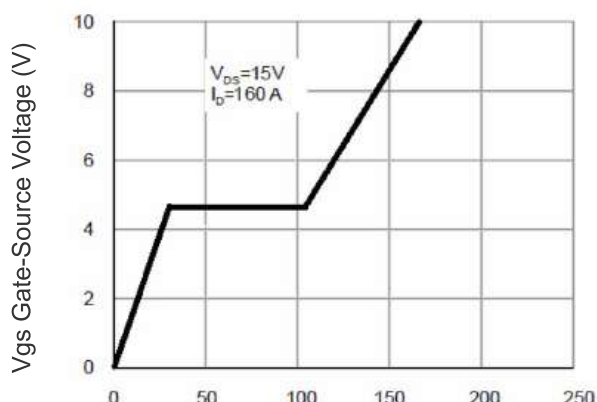
V<sub>ds</sub> Drain-Source Voltage (V)  
Figure 1 Output Characteristics



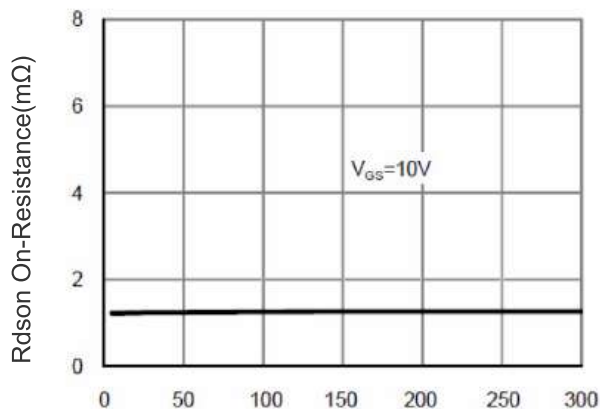
T<sub>J</sub> -Junction Temperature(°C)  
Figure 4 Rdson-Junction Temperature



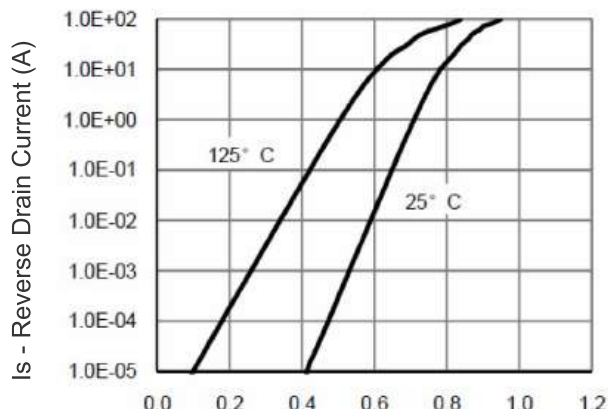
V<sub>gs</sub> Gate-Source Voltage (V)  
Figure 2 Transfer Characteristics



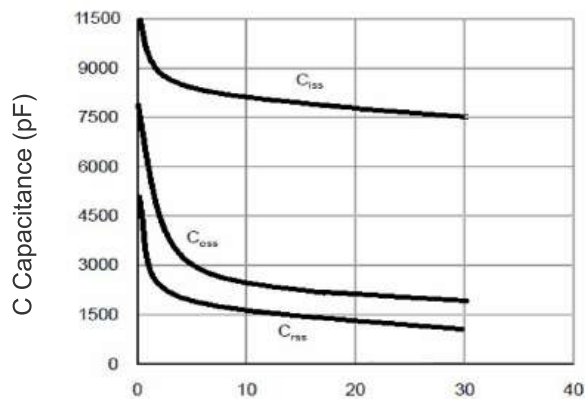
Q<sub>g</sub> Gate Charge (nC)  
Figure 5 Gate Charge



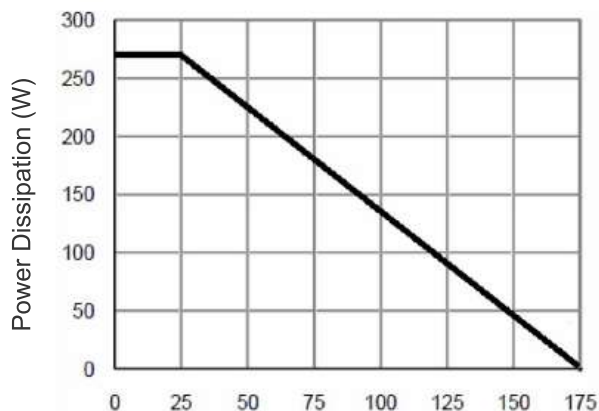
I<sub>D</sub> - Drain Current (A)  
Figure 3 Rdson- Drain Current



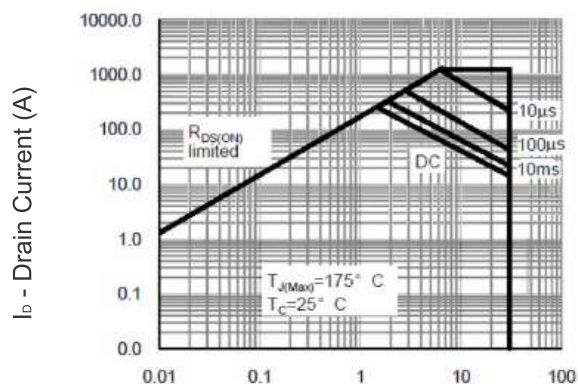
V<sub>sd</sub> Source-Drain Voltage (V)  
Figure 6 Source- Drain Diode Forward



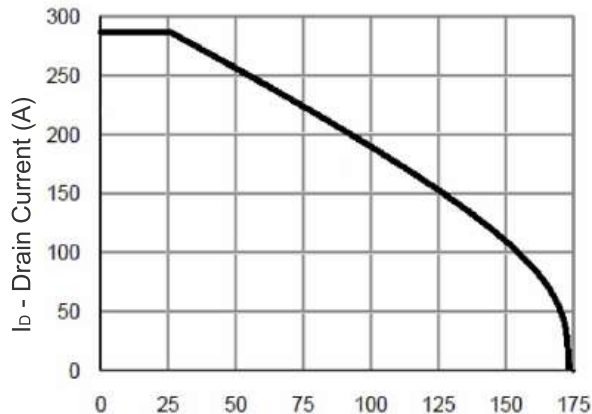
Vds Drain-Source Voltage (V)  
Figure 7 Capacitance vs Vds



TJ -Junction Temperature(°C)  
Figure 9 Power De-rating



Vds Drain-Source Voltage (V)  
Figure 8 Safe Operation Area



TJ -Junction Temperature(°C)  
Figure 10 Current vs Junction Temperature

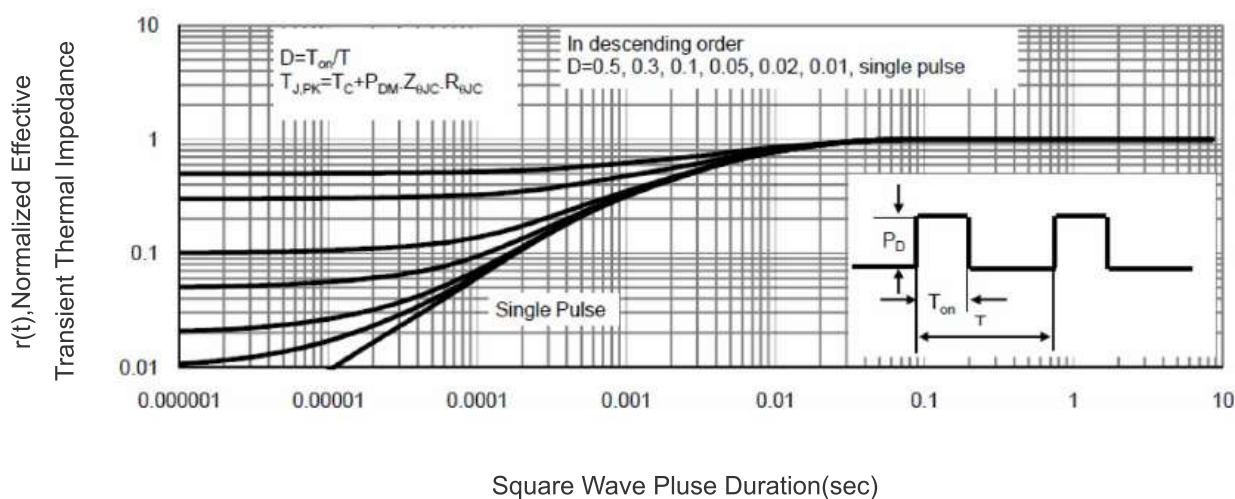
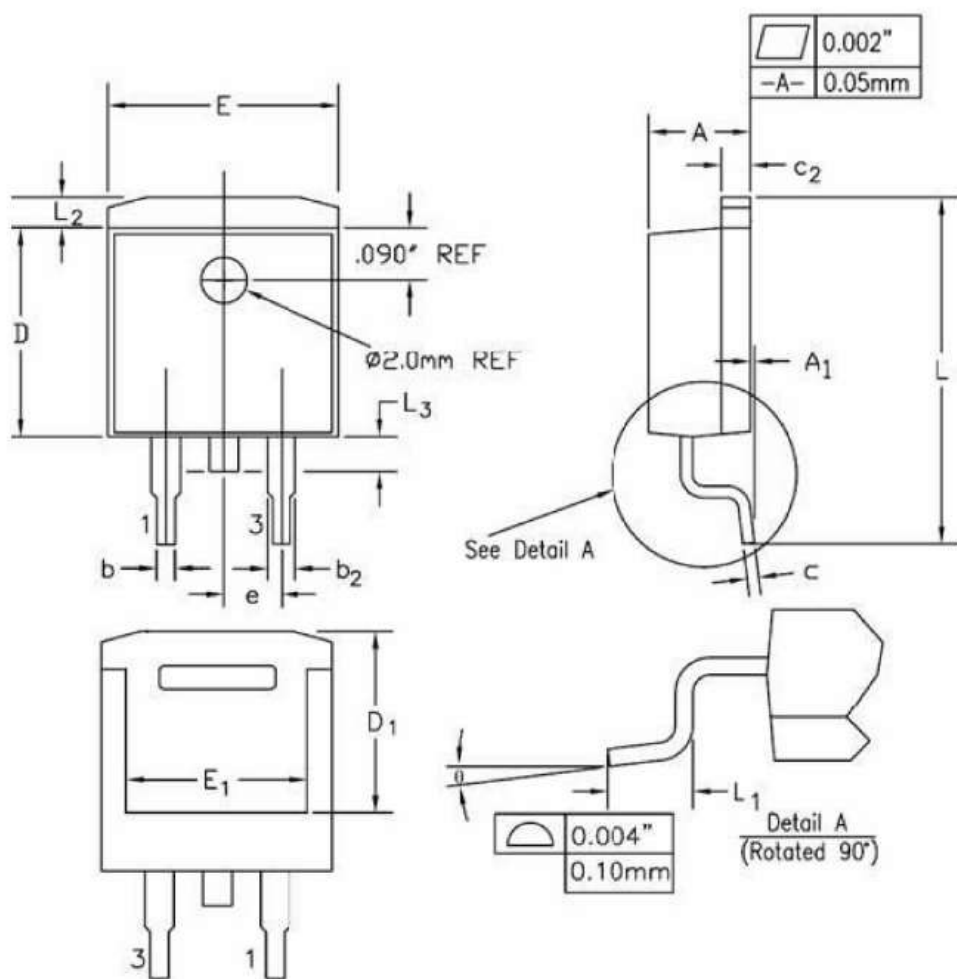


Figure 11 Normalized Maximum Transient Thermal Impedance

## TO-263-2L Package Information



SYMBOL	INCHES		MILLIMETERS		NOTES
	MIN	MAX	MIN	MAX	
A	0.170	0.180	4.32	4.57	
A1	-	0.010	-	0.25	
b	0.028	0.037	0.71	0.94	
b2	0.045	0.055	1.15	1.40	
c	0.018	0.024	0.46	0.61	
c2	0.048	0.055	1.22	1.40	
D	0.350	0.370	8.89	9.40	
D1	0.315	0.324	8.01	8.23	
E	0.395	0.405	10.04	10.28	
E1	0.310	0.318	7.88	8.08	
e	0.100 BSC.		2.54 BSC.		
L	0.580	0.620	14.73	15.75	
L1	0.090	0.110	2.29	2.79	
L2	0.045	0.055	1.15	1.39	
L3	0.050	0.070	1.27	1.77	
$\theta$	0°	8°	0°	8°	



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